Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.		SERIAL NO. New U.S. PCT Application		
				263788US2PCT		Based on PCT/JP03/12563		
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				FILING DATE		GROUP 1763		
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
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/M.A./	AO	0 955 665	11/10/99	EP			NO	
/M.A./	AP	2000-58465	02/25/00	JP(Equivalent to EP 0 961 307)			NO	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW							
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	AZ				☐ Addi	tional Refe	rences sheet(s) attached	
Examiner		/Maureen Arancibia/				Date Considered 07/23/2007		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609: Draw line through citation if not in								
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